

Final datasheet  
CoolSiC™ 1200 V SiC MOSFET G2 : Silicon Carbide MOSFET with .XT interconnection technology

Features

- $V_{DS} = 1200\text{ V}$  at  $T_{vj} = 25^{\circ}\text{C}$
- $I_{DC} = 34\text{ A}$  at  $T_C = 100^{\circ}\text{C}$
- $R_{DS(on)} = 40\text{ m}\Omega$  at  $V_{GS} = 18\text{ V}$ ,  $T_{vj} = 25^{\circ}\text{C}$
- Very low switching losses
- Overload operation up to  $T_{vj} = 200^{\circ}\text{C}$
- Short circuit withstand time  $2\text{ }\mu\text{s}$
- Benchmark gate threshold voltage,  $V_{GS(th)} = 4.2\text{ V}$
- Robust against parasitic turn on,  $0\text{ V}$  turn-off gate voltage can be applied
- Robust body diode for hard commutation
- .XT interconnection technology for best-in-class thermal performance
- Suitable Infineon gate drivers can be found under <https://www.infineon.com/gdfinder>

Potential applications

- General purpose drives (GPD)
- EV Charging
- Online UPS/Industrial UPS
- Solar power optimizer
- String inverter
- Energy Storage Systems (ESS)
- Welding

Product validation

- Qualified for industrial applications according to the relevant tests of JEDEC47/20/22

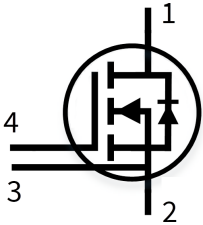
Description

- 1 – drain
- 2 – source
- 3 – Kelvin sense contact
- 4 – gate

Note: the source and sense pins are not exchangeable, their exchange might lead to malfunction



- Halogen-free
- Green
- Lead-free
- RoHS



| Type           | Package        | Marking  |
|----------------|----------------|----------|
| IMZC120R040M2H | PG-TO247-4-U07 | 12M2H040 |



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## 1 Package

**Table 1** Characteristic values

| Parameter                                           | Symbol        | Note or test condition                                                     | Values |      |      | Unit |
|-----------------------------------------------------|---------------|----------------------------------------------------------------------------|--------|------|------|------|
|                                                     |               |                                                                            | Min.   | Typ. | Max. |      |
| Storage temperature                                 | $T_{stg}$     |                                                                            | -55    |      | 150  | °C   |
| Soldering temperature                               | $T_{sold}$    | wave soldering only allowed at leads 1.6 mm (0.063 in.) from case for 10 s |        |      | 260  | °C   |
| Mounting torque                                     | $M$           | M3 screw, Maximum of mounting processes: 3                                 |        |      | 0.6  | Nm   |
| Thermal resistance, junction-ambient                | $R_{th(j-a)}$ |                                                                            |        |      | 62   | K/W  |
| MOSFET/body diode thermal resistance, junction-case | $R_{th(j-c)}$ |                                                                            |        | 0.53 | 0.69 | K/W  |

## 2 MOSFET

**Table 2** Maximum rated values

| Parameter                                                                    | Symbol    | Note or test condition                                                                                                   |                       | Values   | Unit          |
|------------------------------------------------------------------------------|-----------|--------------------------------------------------------------------------------------------------------------------------|-----------------------|----------|---------------|
| Drain-source voltage                                                         | $V_{DSS}$ | $T_{vj} \geq 25\text{ °C}$                                                                                               |                       | 1200     | V             |
| Continuous DC drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$ | $I_{DDC}$ | $V_{GS} = 18\text{ V}$                                                                                                   | $T_c = 25\text{ °C}$  | 48       | A             |
|                                                                              |           |                                                                                                                          | $T_c = 100\text{ °C}$ | 34       |               |
| Peak drain current, $t_p$ limited by $T_{vj(max)}$ <sup>1)</sup>             | $I_{DM}$  | $V_{GS} = 18\text{ V}$                                                                                                   |                       | 102      | A             |
| Gate-source voltage, max. transient voltage                                  | $V_{GS}$  | $t_p \leq 0.5\text{ }\mu\text{s}$ , $D < 0.01$                                                                           |                       | -10...25 | V             |
| Gate-source voltage, max. static voltage <sup>2)</sup>                       | $V_{GS}$  |                                                                                                                          |                       | -7...23  | V             |
| Avalanche energy, single pulse                                               | $E_{AS}$  | $I_D = 18\text{ A}$ , $V_{DD} = 50\text{ V}$ , $L = 1.4\text{ mH}$ , $T_{vj(start)} = 25\text{ °C}$                      |                       | 220      | mJ            |
| Avalanche energy, repetitive                                                 | $E_{AR}$  | $I_D = 18\text{ A}$ , $V_{DD} = 50\text{ V}$ , $L = 6.8\text{ }\mu\text{H}$ , $T_{vj(start)} = 25\text{ °C}$             |                       | 1.1      | mJ            |
| Short-circuit withstand time                                                 | $t_{SC}$  | $V_{DD} \leq 800\text{ V}$ , $V_{DS,peak} < 1200\text{ V}$ , $V_{GS(on)} = 15\text{ V}$ , $T_{vj(start)} = 25\text{ °C}$ |                       | 2        | $\mu\text{s}$ |
| Power dissipation, limited by $T_{vj(max)}$                                  | $P_{tot}$ |                                                                                                                          | $T_c = 25\text{ °C}$  | 218      | W             |
|                                                                              |           |                                                                                                                          | $T_c = 100\text{ °C}$ | 109      |               |

1) Verified by design.

2) The maximum gate-source voltage in the application design should be in accordance to IPC-9592B.

**Table 3 Recommended values**

| Parameter                         | Symbol        | Note or test condition | Values  | Unit |
|-----------------------------------|---------------|------------------------|---------|------|
| Recommended turn-on gate voltage  | $V_{GS(on)}$  |                        | 15...18 | V    |
| Recommended turn-off gate voltage | $V_{GS(off)}$ |                        | -5...0  | V    |

**Table 4 Characteristic values**

| Parameter                                    | Symbol       | Note or test condition                                                                                                                                 | Values |                                                          |      | Unit |
|----------------------------------------------|--------------|--------------------------------------------------------------------------------------------------------------------------------------------------------|--------|----------------------------------------------------------|------|------|
|                                              |              |                                                                                                                                                        | Min.   | Typ.                                                     | Max. |      |
| Drain-source on-state resistance             | $R_{DS(on)}$ | $I_D = 18\text{ A}$                                                                                                                                    |        | $T_{vj} = 25\text{ °C}$ ,<br>$V_{GS(on)} = 18\text{ V}$  | 40   | mΩ   |
|                                              |              |                                                                                                                                                        |        | $T_{vj} = 150\text{ °C}$ ,<br>$V_{GS(on)} = 18\text{ V}$ | 81   |      |
|                                              |              |                                                                                                                                                        |        | $T_{vj} = 175\text{ °C}$ ,<br>$V_{GS(on)} = 18\text{ V}$ | 94   |      |
|                                              |              |                                                                                                                                                        |        | $T_{vj} = 25\text{ °C}$ ,<br>$V_{GS(on)} = 15\text{ V}$  | 49   |      |
| Gate-source threshold voltage                | $V_{GS(th)}$ | $I_D = 5.5\text{ mA}$ , $V_{DS} = V_{GS}$<br>(tested after 1 ms pulse at $V_{GS} = 20\text{ V}$ )                                                      |        | $T_{vj} = 25\text{ °C}$                                  | 3.5  | V    |
|                                              |              |                                                                                                                                                        |        | $T_{vj} = 175\text{ °C}$                                 | 4.2  |      |
| Zero gate-voltage drain current              | $I_{DSS}$    | $V_{DS} = 1200\text{ V}$ , $V_{GS} = 0\text{ V}$                                                                                                       |        | $T_{vj} = 25\text{ °C}$                                  | 150  | μA   |
|                                              |              |                                                                                                                                                        |        | $T_{vj} = 175\text{ °C}$                                 | 3    |      |
| Gate leakage current                         | $I_{GSS}$    | $V_{DS} = 0\text{ V}$                                                                                                                                  |        | $V_{GS} = 23\text{ V}$                                   | 120  | nA   |
|                                              |              |                                                                                                                                                        |        | $V_{GS} = -10\text{ V}$                                  | -120 |      |
| Forward transconductance                     | $g_{fs}$     | $I_D = 18\text{ A}$ , $V_{DS} = 20\text{ V}$                                                                                                           |        | 12                                                       |      | S    |
| Internal gate resistance                     | $R_{G,int}$  | $f = 1\text{ MHz}$ , $V_{AC} = 25\text{ mV}$                                                                                                           |        | 6.5                                                      |      | Ω    |
| Input capacitance                            | $C_{iss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$                                                       |        | 1310                                                     |      | pF   |
| Output capacitance                           | $C_{oss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$                                                       |        | 55                                                       |      | pF   |
| Reverse transfer capacitance                 | $C_{rss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$                                                       |        | 5                                                        |      | pF   |
| $C_{oss}$ stored energy                      | $E_{oss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$                                                       |        | 23                                                       |      | μJ   |
| Output charge                                | $Q_{oss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ ,<br>$V_{AC} = 25\text{ mV}$ , Calculated by $C_{oss} \cdot f(V_{DS})$ @100 kHz |        | 85                                                       |      | nC   |
| Effective output capacitance, energy related | $C_{o(er)}$  | $V_{DD} = 0...800\text{ V}$ , $V_{GS} = 0\text{ V}$                                                                                                    |        | 72                                                       |      | pF   |
| Effective output capacitance, time related   | $C_{o(tr)}$  | $I_D = \text{constant}$ , $V_{DD} = 0...800\text{ V}$ , $V_{GS} = 0\text{ V}$                                                                          |        | 106                                                      |      | pF   |

(table continues...)

**Table 4** (continued) **Characteristic values**

| Parameter            | Symbol       | Note or test condition                                                                                                                                                                                                      | Values                                |      |      | Unit          |
|----------------------|--------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------|------|------|---------------|
|                      |              |                                                                                                                                                                                                                             | Min.                                  | Typ. | Max. |               |
| Total gate charge    | $Q_G$        | $V_{DD} = 800 \text{ V}$ , $I_D = 18 \text{ A}$ , $V_{GS} = 0/18 \text{ V}$ , turn-on pulse                                                                                                                                 |                                       | 39   |      | nC            |
| Plateau gate charge  | $Q_{GS(pl)}$ | $V_{DD} = 800 \text{ V}$ , $I_D = 18 \text{ A}$ , $V_{GS} = 0/18 \text{ V}$ , turn-on pulse                                                                                                                                 |                                       | 8    |      | nC            |
| Gate-to-drain charge | $Q_{GD}$     | $V_{DD} = 800 \text{ V}$ , $I_D = 18 \text{ A}$ , $V_{GS} = 0/18 \text{ V}$ , turn-on pulse                                                                                                                                 |                                       | 10   |      | nC            |
| Turn-on delay time   | $t_{d(on)}$  | $V_{DD} = 800 \text{ V}$ , $I_D = 18 \text{ A}$ ,<br>$V_{GS} = 0/18 \text{ V}$ ,<br>$R_{GS(on)} = 2.3 \Omega$ ,<br>$R_{GS(off)} = 2.3 \Omega$ ,<br>$L_\sigma = 18 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$ | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 4.8  |      | ns            |
|                      |              |                                                                                                                                                                                                                             | $T_{vj} = 175 \text{ }^\circ\text{C}$ | 4.3  |      |               |
| Rise time            | $t_r$        | $V_{DD} = 800 \text{ V}$ , $I_D = 18 \text{ A}$ ,<br>$V_{GS} = 0/18 \text{ V}$ ,<br>$R_{GS(on)} = 2.3 \Omega$ ,<br>$R_{GS(off)} = 2.3 \Omega$ ,<br>$L_\sigma = 18 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$ | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 5.8  |      | ns            |
|                      |              |                                                                                                                                                                                                                             | $T_{vj} = 175 \text{ }^\circ\text{C}$ | 5.4  |      |               |
| Turn-off delay time  | $t_{d(off)}$ | $V_{DD} = 800 \text{ V}$ , $I_D = 18 \text{ A}$ ,<br>$V_{GS} = 0/18 \text{ V}$ ,<br>$R_{GS(on)} = 2.3 \Omega$ ,<br>$R_{GS(off)} = 2.3 \Omega$ ,<br>$L_\sigma = 18 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$ | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 10.6 |      | ns            |
|                      |              |                                                                                                                                                                                                                             | $T_{vj} = 175 \text{ }^\circ\text{C}$ | 18.5 |      |               |
| Fall time            | $t_f$        | $V_{DD} = 800 \text{ V}$ , $I_D = 18 \text{ A}$ ,<br>$V_{GS} = 0/18 \text{ V}$ ,<br>$R_{GS(on)} = 2.3 \Omega$ ,<br>$R_{GS(off)} = 2.3 \Omega$ ,<br>$L_\sigma = 18 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$ | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 6.1  |      | ns            |
|                      |              |                                                                                                                                                                                                                             | $T_{vj} = 175 \text{ }^\circ\text{C}$ | 7.2  |      |               |
| Turn-on energy       | $E_{on}$     | $V_{DD} = 800 \text{ V}$ , $I_D = 18 \text{ A}$ ,<br>$V_{GS} = 0/18 \text{ V}$ ,<br>$R_{GS(on)} = 2.3 \Omega$ ,<br>$R_{GS(off)} = 2.3 \Omega$ ,<br>$L_\sigma = 18 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$ | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 123  |      | $\mu\text{J}$ |
|                      |              |                                                                                                                                                                                                                             | $T_{vj} = 175 \text{ }^\circ\text{C}$ | 252  |      |               |
| Turn-off energy      | $E_{off}$    | $V_{DD} = 800 \text{ V}$ , $I_D = 18 \text{ A}$ ,<br>$V_{GS} = 0/18 \text{ V}$ ,<br>$R_{GS(on)} = 2.3 \Omega$ ,<br>$R_{GS(off)} = 2.3 \Omega$ ,<br>$L_\sigma = 18 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$ | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 32   |      | $\mu\text{J}$ |
|                      |              |                                                                                                                                                                                                                             | $T_{vj} = 175 \text{ }^\circ\text{C}$ | 55   |      |               |

(table continues...)

3 Body diode (MOSFET)

Table 4 (continued) Characteristic values

| Parameter                            | Symbol                | Note or test condition                                                                                                                                                                                                                                                    | Values                                         |      |      | Unit               |
|--------------------------------------|-----------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------|------|------|--------------------|
|                                      |                       |                                                                                                                                                                                                                                                                           | Min.                                           | Typ. | Max. |                    |
| Total switching energy <sup>1)</sup> | $E_{\text{tot}}$      | $V_{\text{DD}} = 800 \text{ V}$ , $I_{\text{D}} = 18 \text{ A}$ ,<br>$V_{\text{GS}} = 0/18 \text{ V}$ ,<br>$R_{\text{GS(on)}} = 2.3 \Omega$ ,<br>$R_{\text{GS(off)}} = 2.3 \Omega$ ,<br>$L_{\sigma} = 18 \text{ nH}$ , diode: body diode at $V_{\text{GS}} = 0 \text{ V}$ | $T_{\text{vj}} = 25 \text{ }^{\circ}\text{C}$  | 215  |      | $\mu\text{J}$      |
|                                      |                       |                                                                                                                                                                                                                                                                           | $T_{\text{vj}} = 175 \text{ }^{\circ}\text{C}$ | 458  |      |                    |
| Virtual junction temperature         | $T_{\text{vj}}$       |                                                                                                                                                                                                                                                                           | -55                                            |      | 175  | $^{\circ}\text{C}$ |
| Virtual junction temperature         | $T_{\text{vj(over)}}$ | overload, cumulative max. 100 h <sup>2)</sup>                                                                                                                                                                                                                             |                                                |      | 200  | $^{\circ}\text{C}$ |

1) including  $E_{\text{fr}}$

2) up to 5000 cycles. Maximum  $\Delta T$  limited to 100 K.

**Note:** The chip technology was characterized up to 200 kV/ $\mu\text{s}$ . The measured  $dV/dt$  was limited by measurement test setup and package.

Characteristics at  $T_{\text{vj}} = 25^{\circ}\text{C}$ , unless otherwise specified.

### 3 Body diode (MOSFET)

Table 5 Maximum rated values

| Parameter                                                                  | Symbol           | Note or test condition                           | Values | Unit |
|----------------------------------------------------------------------------|------------------|--------------------------------------------------|--------|------|
| Drain-source voltage                                                       | $V_{\text{DSS}}$ | $T_{\text{vj}} \geq 25 \text{ }^{\circ}\text{C}$ | 1200   | V    |
| Peak reverse drain current, $t_{\text{p}}$ limited by $T_{\text{vj(max)}}$ | $I_{\text{SM}}$  | $V_{\text{GS}} = 0 \text{ V}$                    | 102    | A    |

Table 6 Characteristic values

| Parameter                            | Symbol           | Note or test condition                                                                                                                                                                   | Values                                         |      |      | Unit          |
|--------------------------------------|------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------|------|------|---------------|
|                                      |                  |                                                                                                                                                                                          | Min.                                           | Typ. | Max. |               |
| Drain-source reverse voltage         | $V_{\text{SD}}$  | $I_{\text{SD}} = 18 \text{ A}$ , $V_{\text{GS}} = 0 \text{ V}$                                                                                                                           | $T_{\text{vj}} = 25 \text{ }^{\circ}\text{C}$  | 4.2  | 5.5  | V             |
|                                      |                  |                                                                                                                                                                                          | $T_{\text{vj}} = 100 \text{ }^{\circ}\text{C}$ | 4.11 |      |               |
|                                      |                  |                                                                                                                                                                                          | $T_{\text{vj}} = 175 \text{ }^{\circ}\text{C}$ | 4.05 |      |               |
| MOSFET forward recovery charge       | $Q_{\text{fr}}$  | $V_{\text{DD}} = 800 \text{ V}$ , $I_{\text{SD}} = 18 \text{ A}$ ,<br>$V_{\text{GS}} = 0 \text{ V}$ , $R_{\text{GS(on)}} = 2.3 \Omega$ ,<br>$Q_{\text{fr}}$ includes also $Q_{\text{C}}$ | $T_{\text{vj}} = 25 \text{ }^{\circ}\text{C}$  | 0.2  |      | $\mu\text{C}$ |
|                                      |                  |                                                                                                                                                                                          | $T_{\text{vj}} = 175 \text{ }^{\circ}\text{C}$ | 0.5  |      |               |
| MOSFET peak forward recovery current | $I_{\text{frm}}$ | $V_{\text{DD}} = 800 \text{ V}$ , $I_{\text{SD}} = 18 \text{ A}$ ,<br>$V_{\text{GS}} = 0 \text{ V}$ , $R_{\text{GS(on)}} = 2.3 \Omega$ ,<br>$Q_{\text{fr}}$ includes also $Q_{\text{C}}$ | $T_{\text{vj}} = 25 \text{ }^{\circ}\text{C}$  | 18.3 |      | A             |
|                                      |                  |                                                                                                                                                                                          | $T_{\text{vj}} = 175 \text{ }^{\circ}\text{C}$ | 45.1 |      |               |

(table continues...)



3 Body diode (MOSFET)

Table 6 (continued) Characteristic values

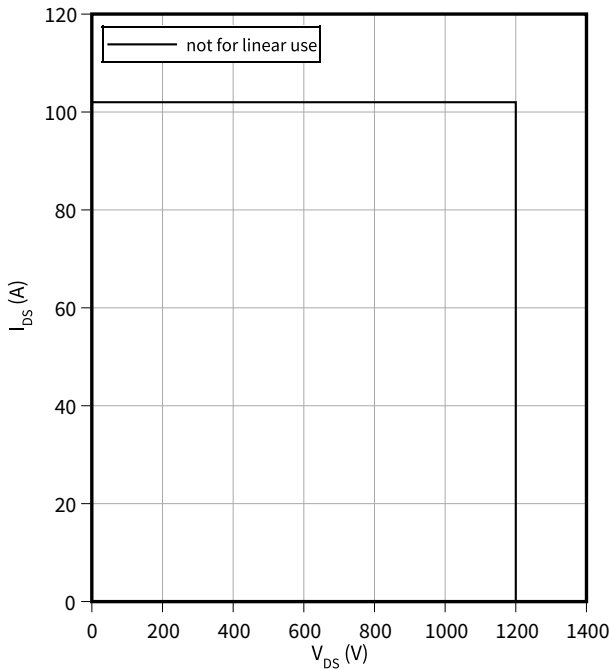
| Parameter                      | Symbol         | Note or test condition                                                                                                                           |                                      | Values |      |      | Unit             |
|--------------------------------|----------------|--------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------|--------|------|------|------------------|
|                                |                |                                                                                                                                                  |                                      | Min.   | Typ. | Max. |                  |
| MOSFET forward recovery energy | $E_{fr}$       | $V_{DD} = 800\text{ V}$ , $I_{SD} = 18\text{ A}$ ,<br>$V_{GS} = 0\text{ V}$ , $R_{GS(on)} = 2.3\text{ }\Omega$ ,<br>$Q_{fr}$ includes also $Q_C$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |        | 60   |      | $\mu\text{J}$    |
|                                |                |                                                                                                                                                  | $T_{vj} = 175\text{ }^\circ\text{C}$ |        | 151  |      |                  |
| Virtual junction temperature   | $T_{vj}$       |                                                                                                                                                  |                                      | -55    |      | 175  | $^\circ\text{C}$ |
| Virtual junction temperature   | $T_{vj(over)}$ | overload, cumulative max. 100 h <sup>1)</sup>                                                                                                    |                                      |        |      | 200  | $^\circ\text{C}$ |

1) up to 5000 cycles. Maximum  $\Delta T$  limited to 100 K.

4 Characteristics diagrams

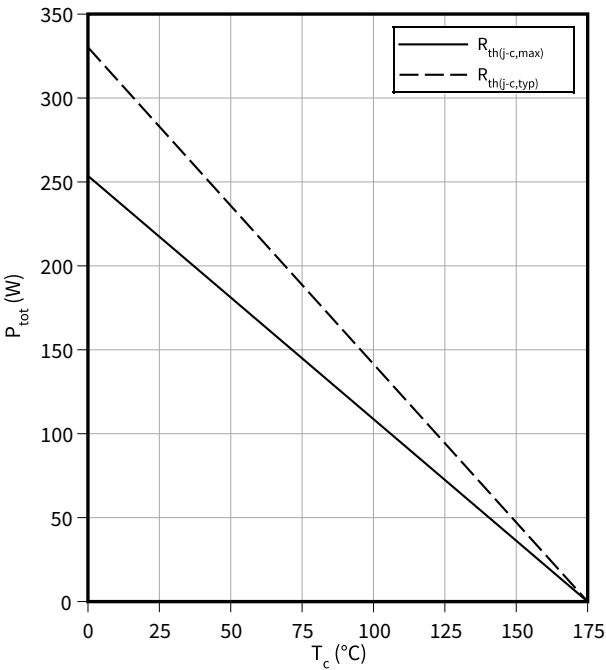
Reverse bias safe operating area (RBSOA)

$I_{DS} = f(V_{DS})$   
 $T_{vj} \leq 200\text{ }^{\circ}\text{C}$ ,  $V_{GS} = 0/18\text{ V}$ ,  $T_c = 25\text{ }^{\circ}\text{C}$



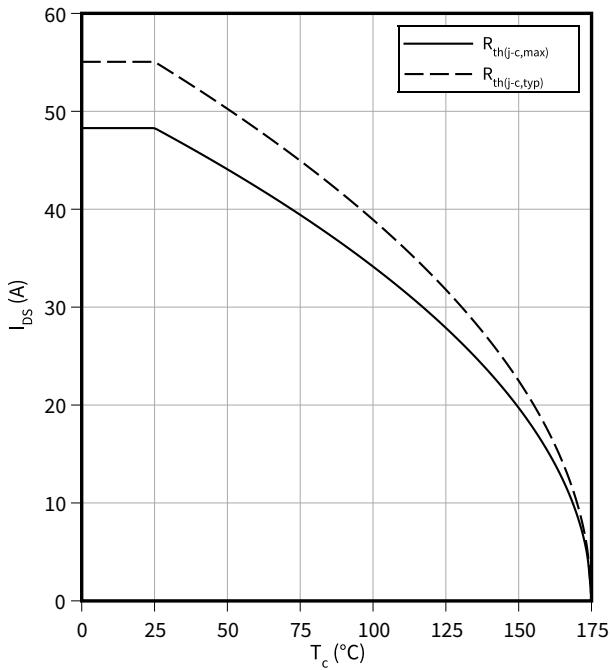
Power dissipation as a function of case temperature

$P_{tot} = f(T_c)$



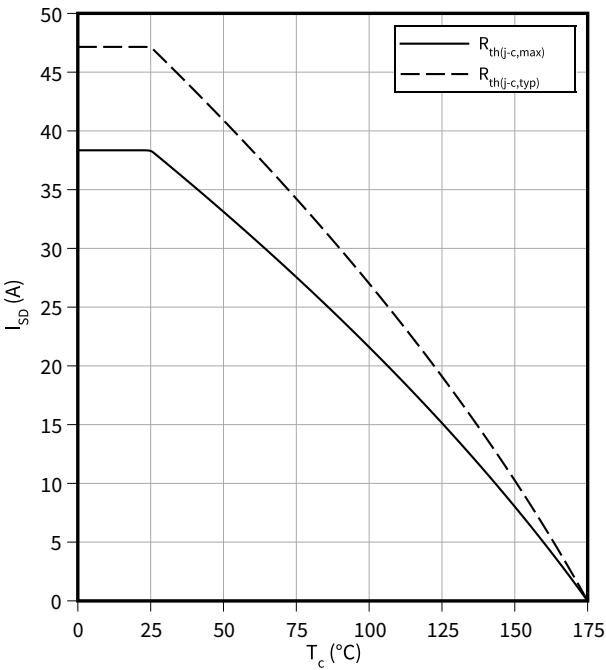
Maximum DC drain to source current as a function of case temperature limited by bond wire

$I_{DS} = f(T_c)$



Maximum source to drain current as a function of case temperature limited by bond wire

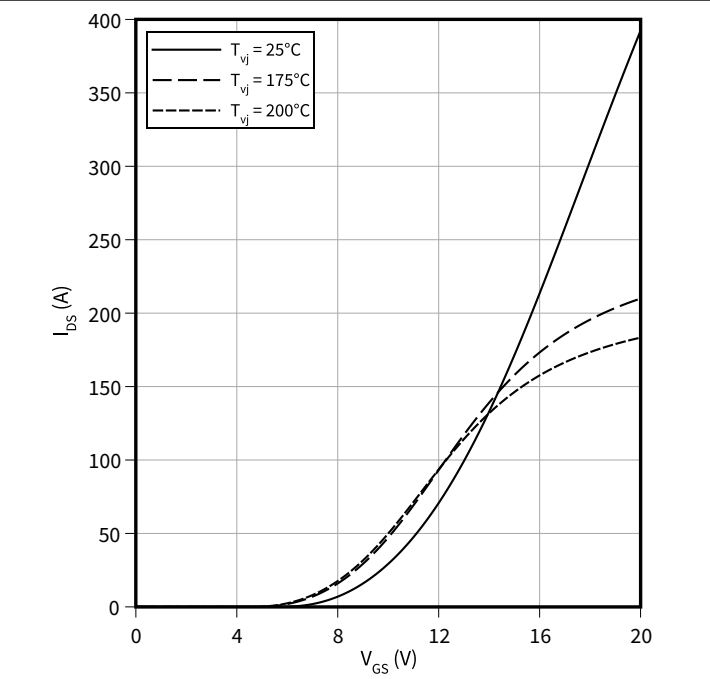
$I_{SD} = f(T_c)$   
 $V_{GS} = 0\text{ V}$



4 Characteristics diagrams

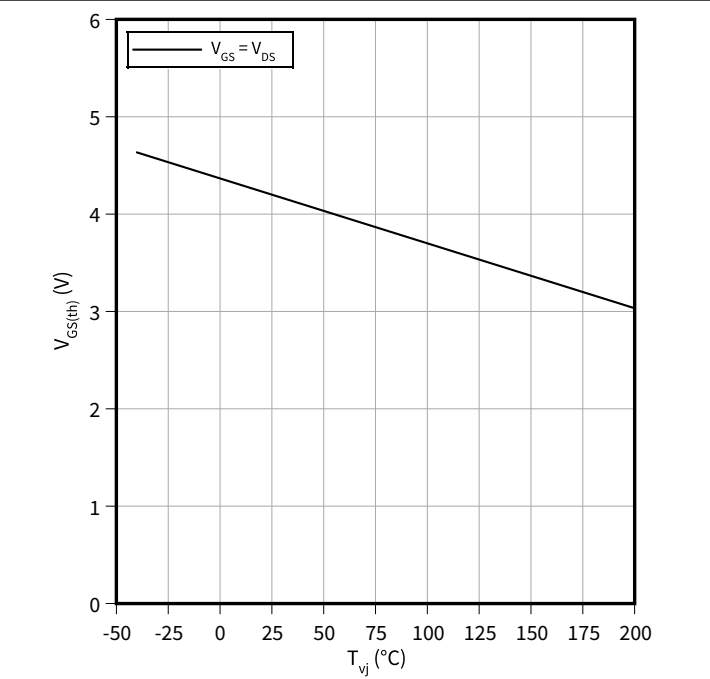
Typical transfer characteristic

$I_{DS} = f(V_{GS})$   
 $V_{DS} = 20\text{ V}$ ,  $t_p = 20\text{ }\mu\text{s}$



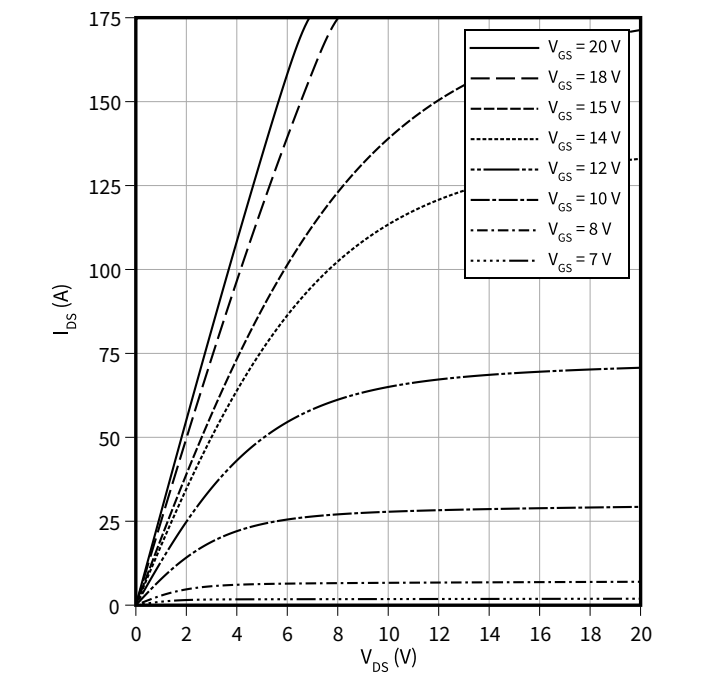
Typical gate-source threshold voltage as a function of junction temperature

$V_{GS(th)} = f(T_{vj})$   
 $I_D = 5.5\text{ mA}$



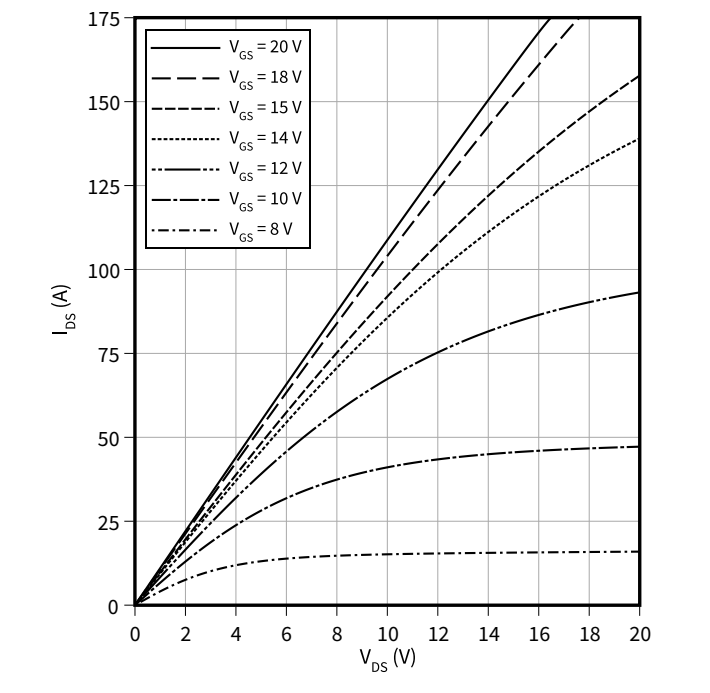
Typical output characteristic,  $V_{GS}$  as parameter

$I_{DS} = f(V_{DS})$   
 $T_{vj} = 25\text{ }^\circ\text{C}$ ,  $t_p = 20\text{ }\mu\text{s}$



Typical output characteristic,  $V_{GS}$  as parameter

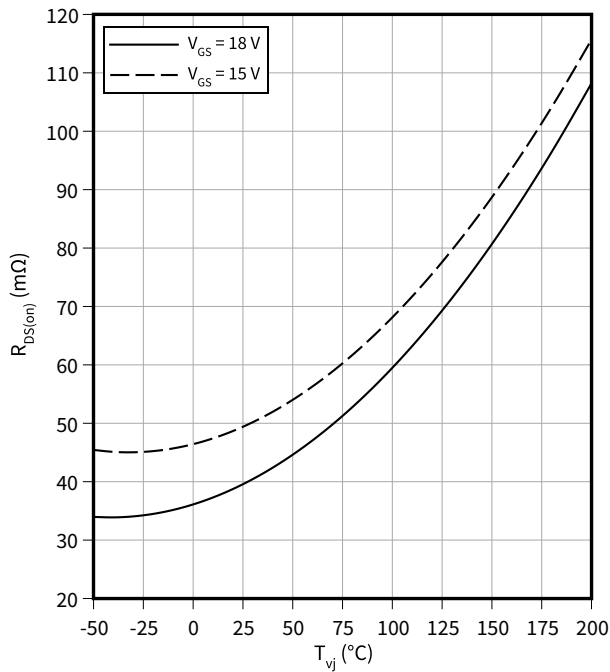
$I_{DS} = f(V_{DS})$   
 $T_{vj} = 175\text{ }^\circ\text{C}$ ,  $t_p = 20\text{ }\mu\text{s}$



4 Characteristics diagrams

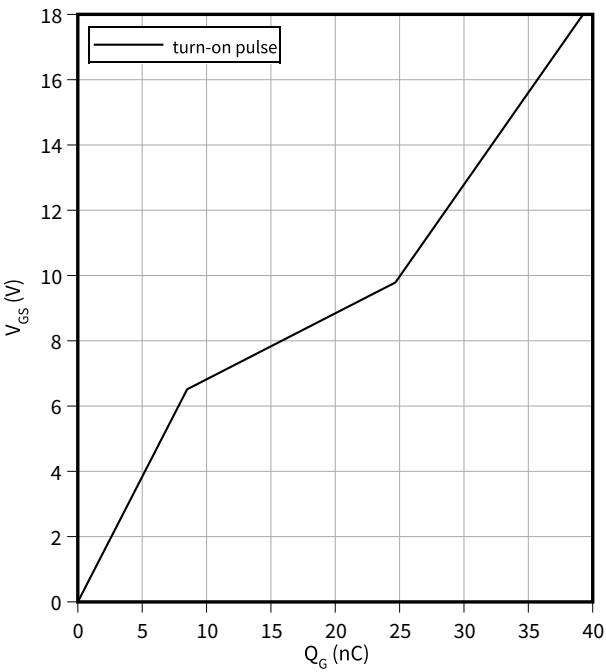
Typical on-state resistance as a function of junction temperature

$R_{DS(on)} = f(T_{vj})$   
 $I_D = 18\text{ A}$



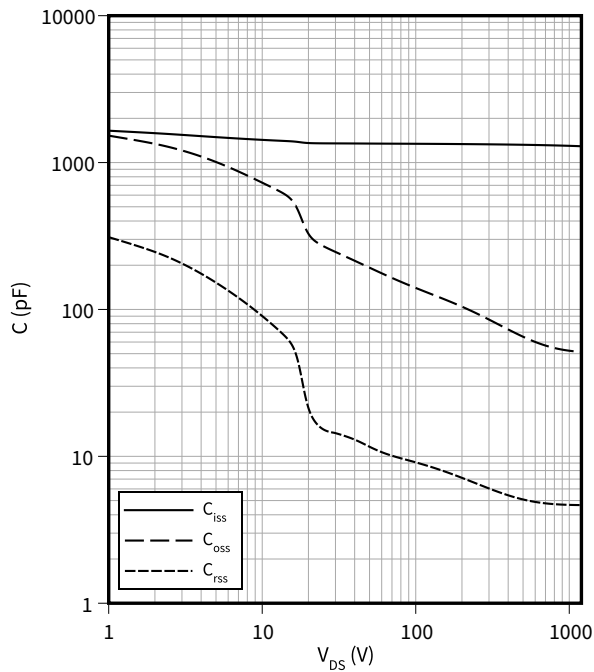
Typical gate charge

$V_{GS} = f(Q_G)$   
 $I_D = 18\text{ A}, V_{DS} = 800\text{ V}$



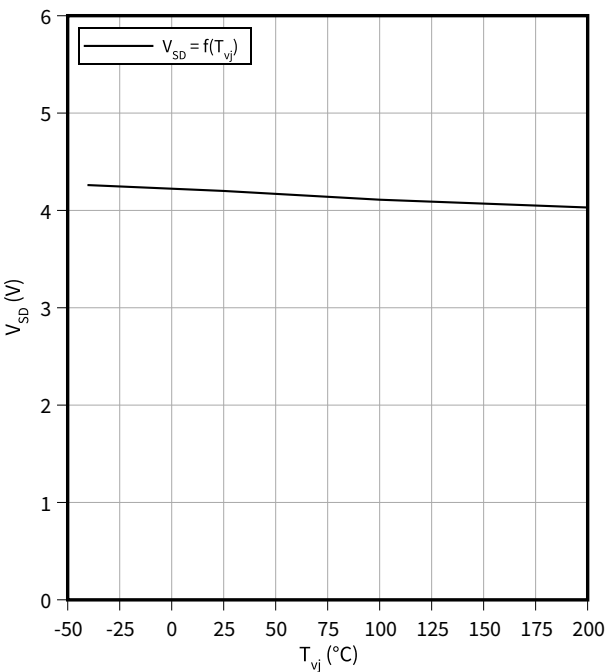
Typical capacitance as a function of drain-source voltage

$C = f(V_{DS})$   
 $f = 100\text{ kHz}, V_{GS} = 0\text{ V}$



Typical reverse drain voltage as function of junction temperature

$V_{SD} = f(T_{vj})$   
 $I_{SD} = 18\text{ A}, V_{GS} = 0\text{ V}$

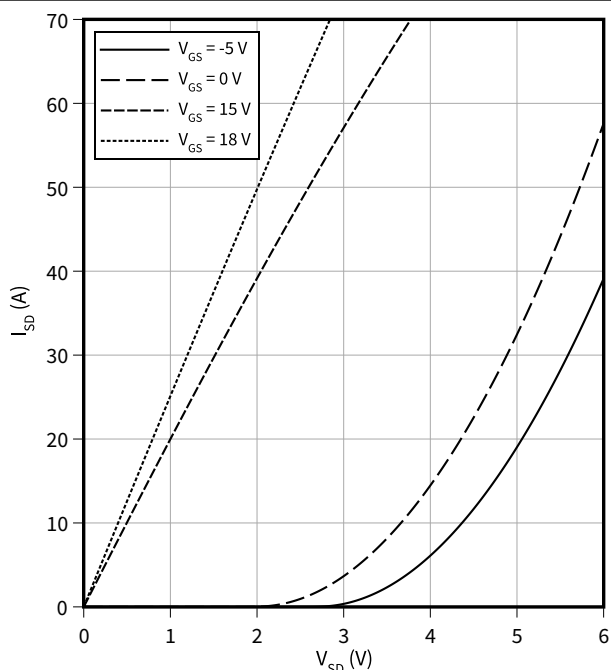


4 Characteristics diagrams

**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$$I_{SD} = f(V_{SD})$$

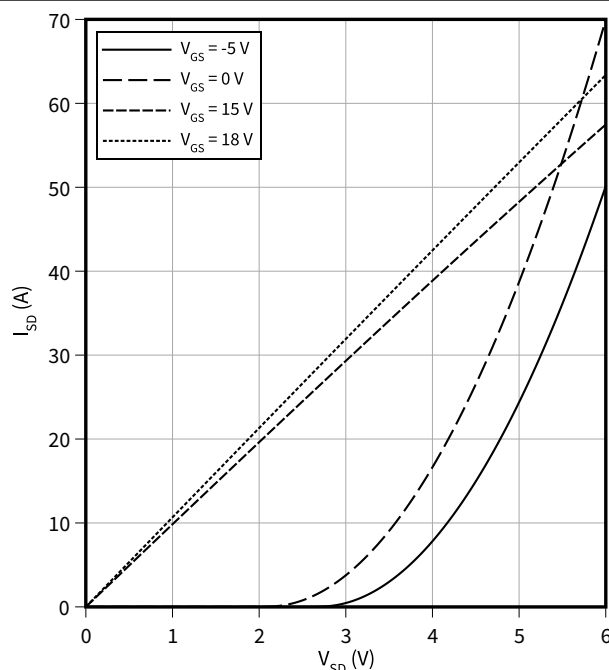
$T_{vj} = 25\text{ °C}$ ,  $t_p = 20\text{ }\mu\text{s}$



**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$$I_{SD} = f(V_{SD})$$

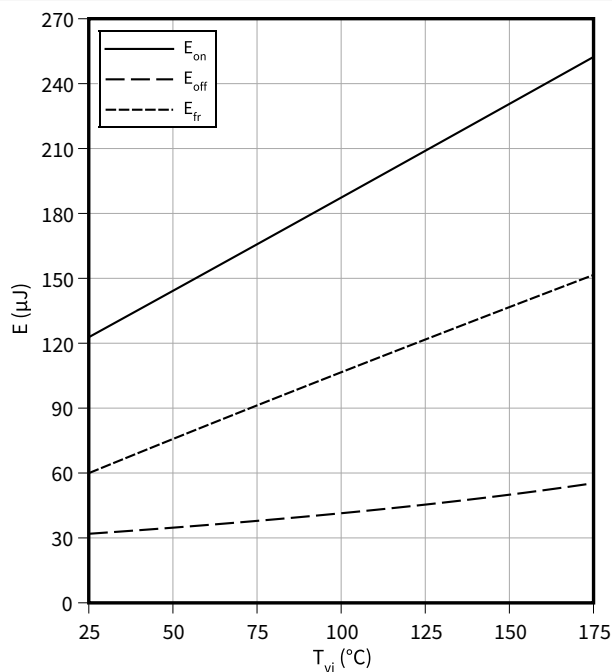
$T_{vj} = 175\text{ °C}$ ,  $t_p = 20\text{ }\mu\text{s}$



**Typical switching energy as a function of junction temperature, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$$E = f(T_{vj})$$

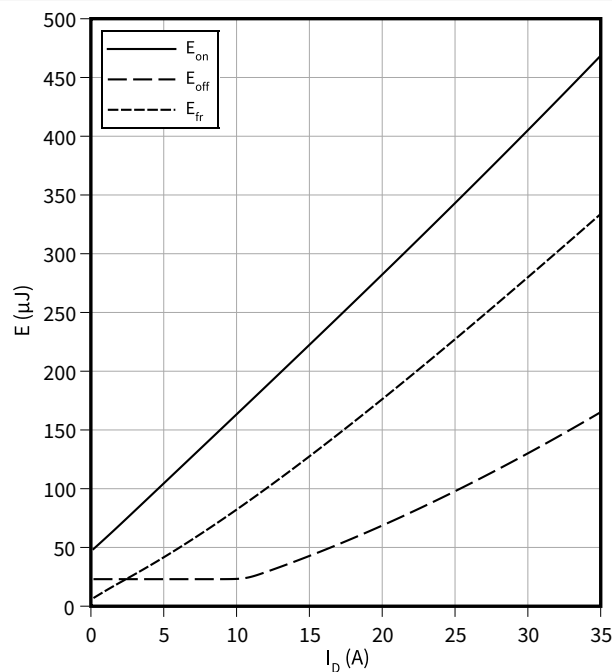
$V_{GS} = 0/18\text{ V}$ ,  $I_D = 18\text{ A}$ ,  $R_{G,ext} = 2.3\text{ }\Omega$ ,  $V_{DD} = 800\text{ V}$



**Typical switching energy as a function of drain current, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$$E = f(I_D)$$

$V_{GS} = 0/18\text{ V}$ ,  $T_{vj} = 175\text{ °C}$ ,  $R_{G,ext} = 2.3\text{ }\Omega$ ,  $V_{DD} = 800\text{ V}$

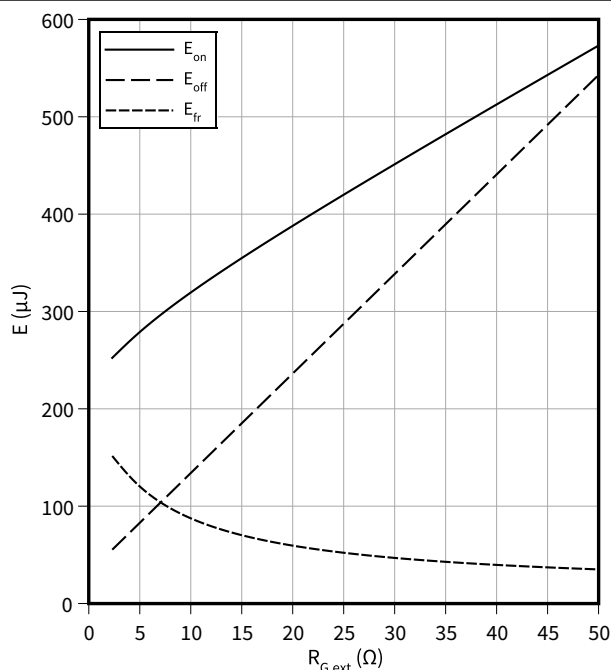


4 Characteristics diagrams

**Typical switching energy as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V**

$$E = f(R_{G,ext})$$

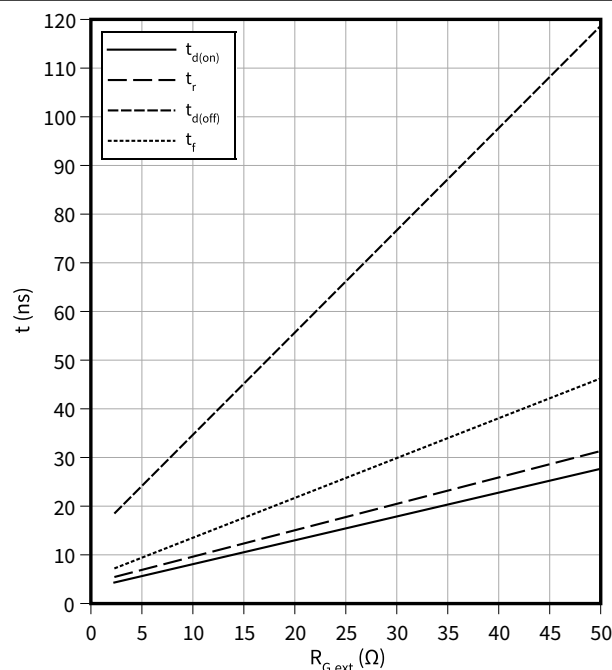
$V_{GS} = 0/18$  V,  $I_D = 18$  A,  $T_{vj} = 175$  °C,  $V_{DD} = 800$  V



**Typical switching times as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V**

$$t = f(R_{G,ext})$$

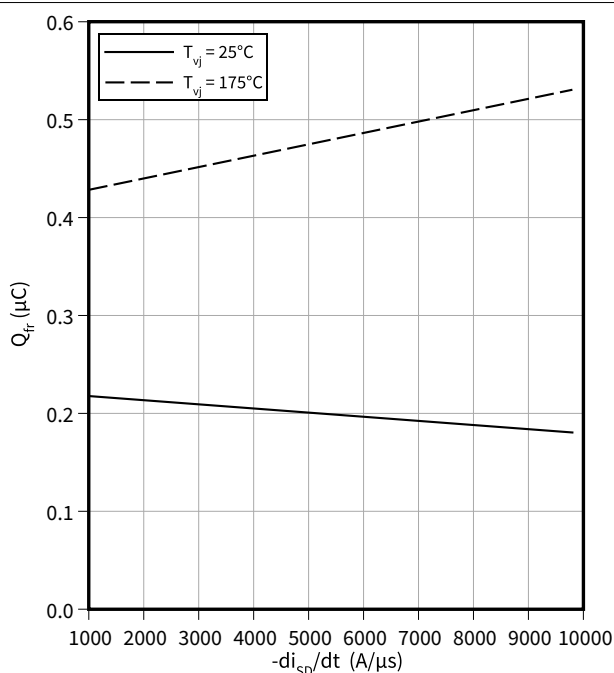
$V_{GS} = 0/18$  V,  $I_D = 18$  A,  $T_{vj} = 175$  °C,  $V_{DD} = 800$  V



**Typical reverse recovery charge as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V**

$$Q_{fr} = f(-di_{SD}/dt)$$

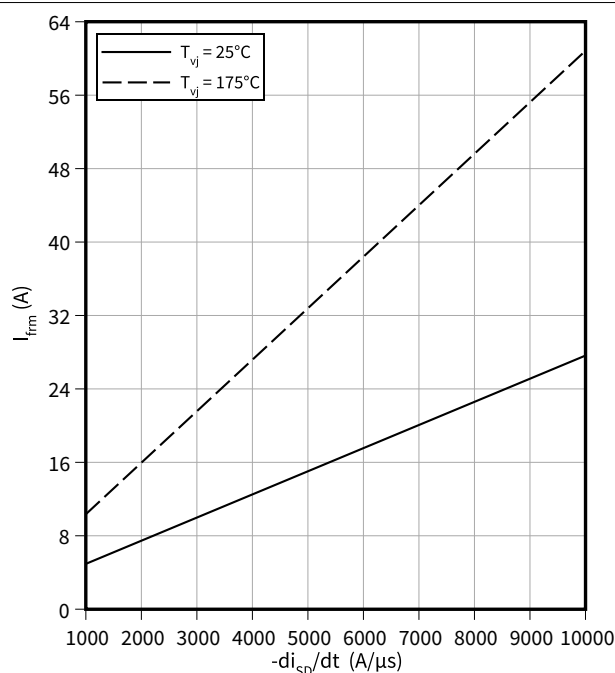
$V_{GS} = 0/18$  V,  $I_{SD} = 18$  A,  $V_{DD} = 800$  V



**Typical reverse recovery current as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V**

$$I_{frm} = f(-di_{SD}/dt)$$

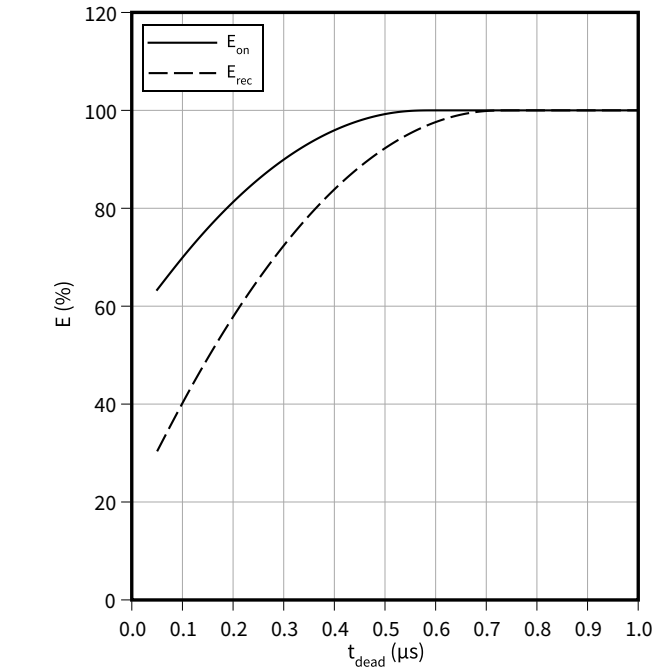
$V_{GS} = 0/18$  V,  $I_{SD} = 18$  A,  $V_{DD} = 800$  V



4 Characteristics diagrams

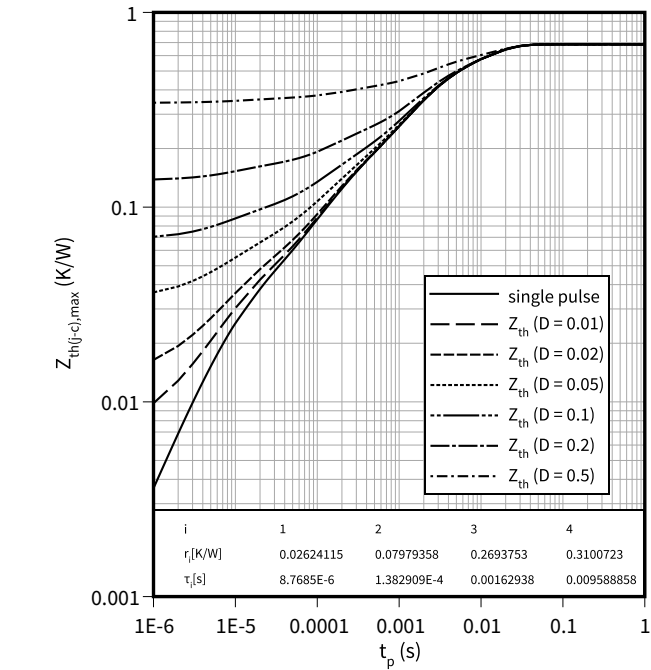
Typical switching energy as a function of dead time / blanking time, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$

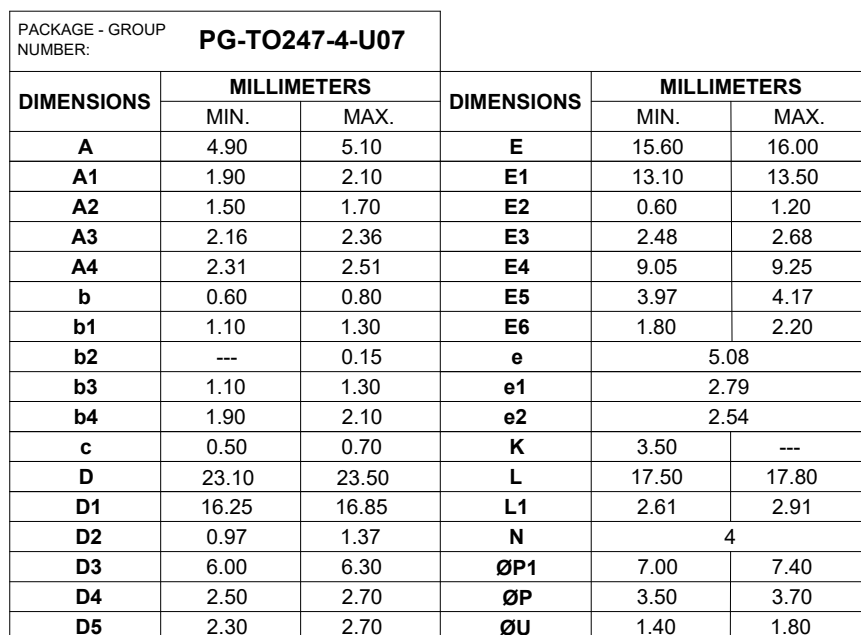
$E = f(t_{dead})$   
 $I_D = 18\text{ A}$ ,  $V_{GS} = 0/18\text{ V}$ ,  $T_{vj} = 175\text{ °C}$ ,  $R_{G,ext} = 2.3\text{ }\Omega$   
 $V_{DD} = 800\text{ V}$



Max. transient thermal impedance (MOSFET/diode)

$Z_{th(j-c),max} = f(t_p)$   
 $D = t_p/T$





### Figure 1

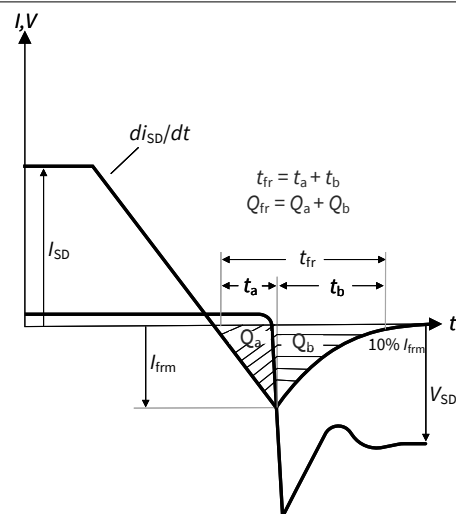


Figure B. **Definition of body diode switching characteristics**

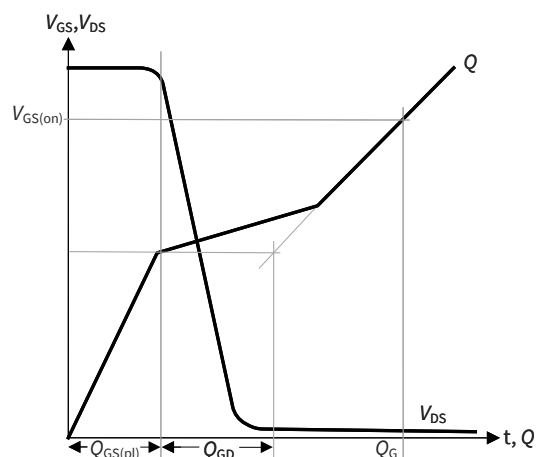
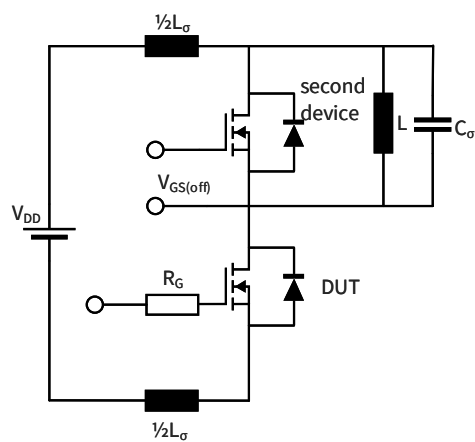
Figure D. **Definition of QGD**

Figure F. **Dynamic test circuit**  
Parasitic inductance  $L_{\sigma}$ ,  
Parasitic capacitor  $C_{\sigma}$ ,



Revision history

Revision history

| Document revision | Date of release | Description of changes |
|-------------------|-----------------|------------------------|
| 0.10              | 2024-09-06      | Preliminary datasheet  |
| 1.00              | 2024-09-26      | Final datasheet        |

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